

# Mid-infrared plasmonic silicon quantum dot/HgCdTe photodetector with ultrahigh specific detectivity

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**Abstract** Highly sensitive photodetectors operating at mid-infrared (MIR) wavelengths are urgently required for the applications of astronomy, optical communication, security monitoring, and so forth. However, further promoting the sensitivity in conventional MIR devices for a higher detectivity is challenging. Among the potential strategies, integrating localized surface plasmon resonance with MIR semiconductors is a promising approach to developing high-performance optoelectronics. Here we demonstrate a high-sensitivity boron (B)-doped silicon quantum dot (Si-QD)/HgCdTe (MCT) MIR photodetector. Because of plasmon-induced hot-hole tunneling and enhanced light absorption, the hybrid photodetector exhibits a high specific detectivity of  $\sim 1.6 \times 10^9$  cm·Hz<sup>1/2</sup>·W<sup>-1</sup> (Jones) and a high-speed response ( $\sim 224$  ns for the rise time and  $\sim 580$  ns for the fall time) at room temperature. Furthermore, the device achieves high-performance spectral blackbody detection with a peak detectivity of up to  $1.6 \times 10^{11}$  Jones at  $\sim 5.8$   $\mu$ m under a cryogenic environment of 77 K, higher than that of bare MCT. This prominent enhancement can be attributed to the further suppression of hot-hole cooling due to a reduced phonon population at low temperatures, which facilitates more efficient hot-carrier extraction and contributes to ultrahigh sensitivity. The plasmonic material-integrated MCT architecture can pave the way for developing high-performance MIR photodetection.

**Keywords** doped silicon quantum dots, HgCdTe, localized surface plasmon resonance, hot-hole tunneling, mid-infrared photodetector

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## 1 Introduction

Photodetectors operating at mid-infrared (MIR) wavelengths play a key role in astronomical work [1], medical diagnosis [2], security monitoring [3], and so on [4–10]. HgCdTe (MCT) [11–13], InSb [14], InGaAs [15], and InAs [16] are primary candidates for MIR applications with mature preparation technology. As a variable bandgap alloy, MCT demonstrates broadband response spectra ranging from 1 to 30  $\mu$ m [17–19]. However, even in a cryogenic environment, MCT detectivity is still far from the theoretical limit [20]. Filling this gap by pursuing state-of-the-art MIR applications is challenging. In recent years, colloidal quantum dots (CQDs) have been considered excellent candidates for optoelectronic devices because of the strong light-matter interaction, quantum confinement effects, and unique carrier dynamics [21–25]. Among all types of CQDs, Si QDs have attracted widespread attention due to their high stability and compatibility with Si-based technologies [26, 27]. Moreover, the highly modifiable localized surface plasmon resonance (LSPR) in the MIR region can be excited in heavily doped Si QDs [28–30]. By confining light into a nanostructure with subwavelength dimensions, LSPR can greatly enhance scattering or absorption at resonance wavelengths [29, 31, 32]. LSPR in plasmonic, heavily doped

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Si QDs can decay nonradiatively through Landau damping and generate hot carriers [30]. Hot carriers with adequate excess kinetic energy can tunnel through the interfacial barrier and contribute to a remarkable photoresponse [33, 34]. Hence, the heavily doped QDs with LSPR can be used to promote MCT performance. In this work, a high-performance B-doped Si-QD/MCT photodetector with an ultrahigh specific detectivity and a fast photoresponse is demonstrated. The LSPR of B-doped Si QDs obviously improves the light absorption in the MIR region. Plasmon-induced hot holes in B-doped Si QDs can participate in photoelectric conversion, resulting in an improved specific detectivity of MCT. In a cryogenic environment (77 K), the sensitivity of the plasmonic Si-QD/MCT photodetector reaches  $\sim 1.6 \times 10^{11} \text{ cm} \cdot \text{Hz}^{1/2} \cdot \text{W}^{-1}$  (Jones) at  $\sim 5.8 \text{ } \mu\text{m}$ . Hot-hole tunneling is adequately fast to prevail over the defect trapping processes in B-doped Si QDs; therefore, the device maintains a high-speed photoresponse, with a rise time of  $\sim 224 \text{ ns}$  and a fall time of  $\sim 580 \text{ ns}$ . These results indicate that combining plasmonic nanostructures with infrared semiconductors is an effective approach for implementing advanced MIR devices.

## 2 Results and discussion

Colloidal B-doped Si QDs were spin-coated on top of MCT to form a Si-QD/MCT hybrid photodetector, and the schematic diagram is shown in Figure 1(a). The thickness of ZnS is  $\sim 10 \text{ nm}$ , which acts as an antireflection coating and prevents the oxidation of MCT. Figure 1(b) illustrates the operation mechanisms of the Si-QD/MCT hybrid devices. First, free-carrier oscillation inside the doped Si QDs is excited by the incident light waves, resulting in strong LSPR and improved light absorption in the MIR region. Then, the hot holes generated in the Si QDs can tunnel through the ZnS layer and enter the MCT, and finally be collected using an external circuit. Si QDs with a B-doping concentration of 13.66% are used in this work. A transmission electron microscopy (TEM) image of the Si QDs is shown in Figures 1(c) and (d). The spherical shape in the TEM images (Figure 1(c)) demonstrates the formation of Si QDs in this work. The EDS mapping reveals the presence of Si and B elements (Figure 1(c)), confirming the B doping in Si QDs. The lattice fringes of the Si QDs can be distinctly observed in the high-resolution transmission electron microscopy (HRTEM) images (Figure 1(d)). The concentric stripes in the selected area electron diffraction (SAED) result (inset of Figure 1(d)) present the good crystallinity of the Si QDs. The statistical results in Figure 1(e) show that the average size of the Si QDs is  $\sim 5.5 \text{ nm}$ . The Fourier transform infrared spectroscopy (FTIR) spectrum of the Si QDs in Figure 1(f) shows that the LSPR peak is located at  $\sim 3.75 \text{ } \mu\text{m}$ . Notably, the LSPR of the B-doped Si QDs can be further tuned by optimizing the doping level and particle size [29, 35].

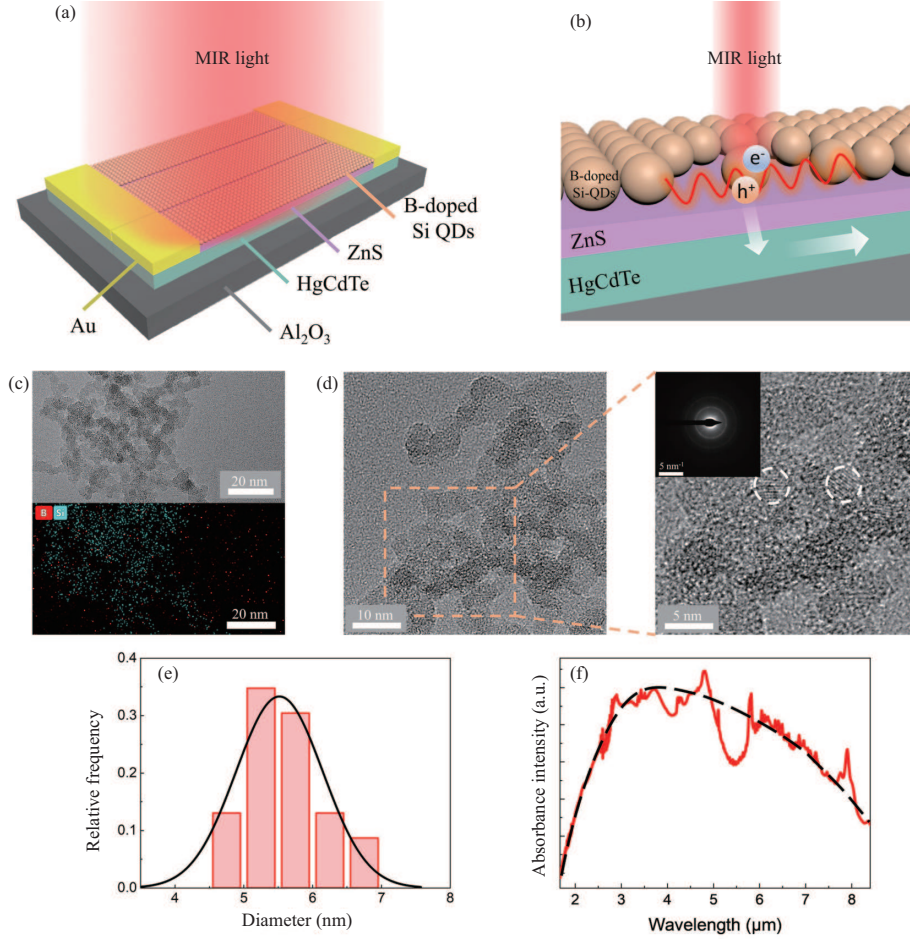
Figure 2(a) illustrates the photoresponse characteristics of the B-doped Si-QD/MCT photodetector under different power densities at  $4 \text{ } \mu\text{m}$ . According to Figure 2(b), when the power density of incident laser gradually changes from  $0.16$  to  $16 \text{ mW} \cdot \text{cm}^{-2}$ , the photocurrent increases from  $0.26$  to  $9.97 \text{ } \mu\text{A}$ . In addition, the photodetector also presents high specific detectivity  $D^*$ , calculated by [36, 37]

$$D^* = R \sqrt{\frac{A}{2eI_{\text{dark}}}}, \quad (1)$$

$$R = \frac{I_{\text{ph}}}{P}, \quad (2)$$

where  $R$  is the responsivity,  $A$  is the sensitive area of the device channel,  $e$  is the electron charge,  $I_{\text{dark}}$  is the dark current,  $I_{\text{ph}}$  is the photocurrent, and  $P$  is the effective power. The maximum specific detectivity can reach  $\sim 1.6 \times 10^9$  Jones at  $4 \text{ } \mu\text{m}$ . In addition, the photocurrent of the hybrid devices can be effectively tuned when applying different bias voltage ( $V_{\text{ds}}$ ), as seen in Figure 2(c). Figure 2(d) shows the specific detectivity of the photodetector under different MIR wavelengths at fixed power density of  $1.6 \text{ mW} \cdot \text{cm}^{-2}$ . The device has a peak specific detectivity located between  $3.4$  and  $4.0 \text{ } \mu\text{m}$ . The device also presents an ultra-fast photoresponse measured at  $2.8 \text{ } \mu\text{m}$ . The rise and fall regions of the curve are well fitted by a single exponential function (Supplementary Information) with  $\sim 224 \text{ ns}$  for the rise time and  $\sim 580 \text{ ns}$  for the fall time (see Figure 2(e)).

Blackbody response is an essential measurement for the sensitivity of infrared photodetectors to reliably assess their potential for practical applications [38]. The blackbody detectivity of the photodetector under different radiation wavelengths ( $D_{\lambda}^*$ ) is obtained by the combination of photocurrent spectra with



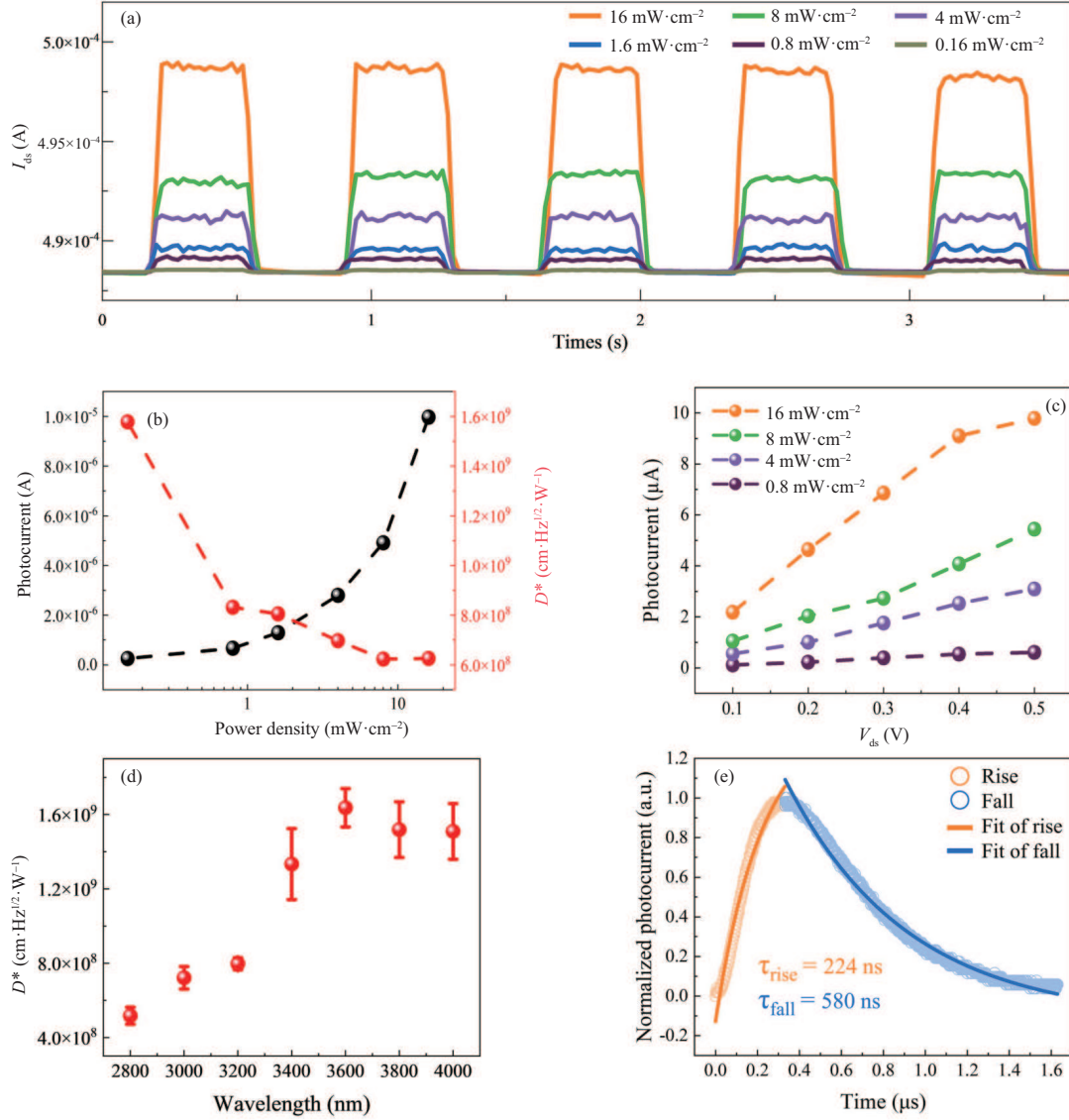
**Figure 1** (Color online) (a) Schematic illustration of the B-doped Si-QD/MCT device structure. (b) Schematic of hot-hole generation and tunneling in the device under MIR light irradiation. (c) TEM and EDS images of the B-doped Si QDs. (d) HRTEM images of the B-doped Si QDs, and the inset is the SAED result (scale bar of inset image is  $5 \text{ nm}^{-1}$ ). (e) Diameter distribution of the B-doped Si QDs. Their size in multiple TEM micrographics was factored into a size distribution histogram and fitted using a Gaussian function. (f) Normalized FTIR spectrum of the B-doped Si QDs.

blackbody response result [12, 39, 40].

$$D^* = \frac{R}{V_n} \sqrt{A \cdot \Delta f}, \quad (3)$$

$$D_\lambda^* = \frac{D^* \cdot f(\lambda)_{\text{FTIR}}}{G}, \quad (4)$$

where  $R$  is blackbody responsivity,  $V_n$  is detector noise voltage,  $\Delta f$  is spectrum analyzer bandwidth,  $f(\lambda)_{\text{FTIR}}$  is the normalized FTIR relative response spectrum (Figure C1, Supporting Information),  $G$  factor is the ratio of the peak responsivity of the detector to the blackbody responsivity, obtained from the relative response spectrum [12]. Figure 3(a) shows the blackbody detectivity of the pure MCT photodetector and B-doped Si-QD/MCT photodetector under blackbody radiation with a bias current of 1 mA at 300 K. The blackbody detectivity of the B-doped Si-QD/MCT photodetector is slightly improved when the wavelength ranges from  $\sim 3$  to  $\sim 4 \mu\text{m}$ , which is in agreement with the absorption peak of the B-doped Si QDs at 300 K. On the other hand, the blackbody detectivity of the MCT devices at low temperature of 77 K is dramatically enhanced after sensitizing with the B-doped Si QDs, see Figure 3(b). The peak blackbody detectivity of B-doped Si-QD/MCT device reaches  $\sim 1.6 \times 10^{11}$  Jones at  $\sim 5.8 \mu\text{m}$ , which is about twice that of pure MCT device. As the temperature drops from 300 to 77 K, the peak blackbody detectivity of MCT devices shifts from  $\sim 4.49$  to  $\sim 5.55 \mu\text{m}$  and the upper spectral response limit shifts from  $\sim 5.34$  to  $\sim 6.91 \mu\text{m}$ , due to the temperature dependent band gap of MCT (Supplementary Information) narrowing from 0.237 to 0.179 eV [41, 42]. In addition, the peak position of enhanced blackbody detectivity in photodetector also shows red-shifts, mainly attributed

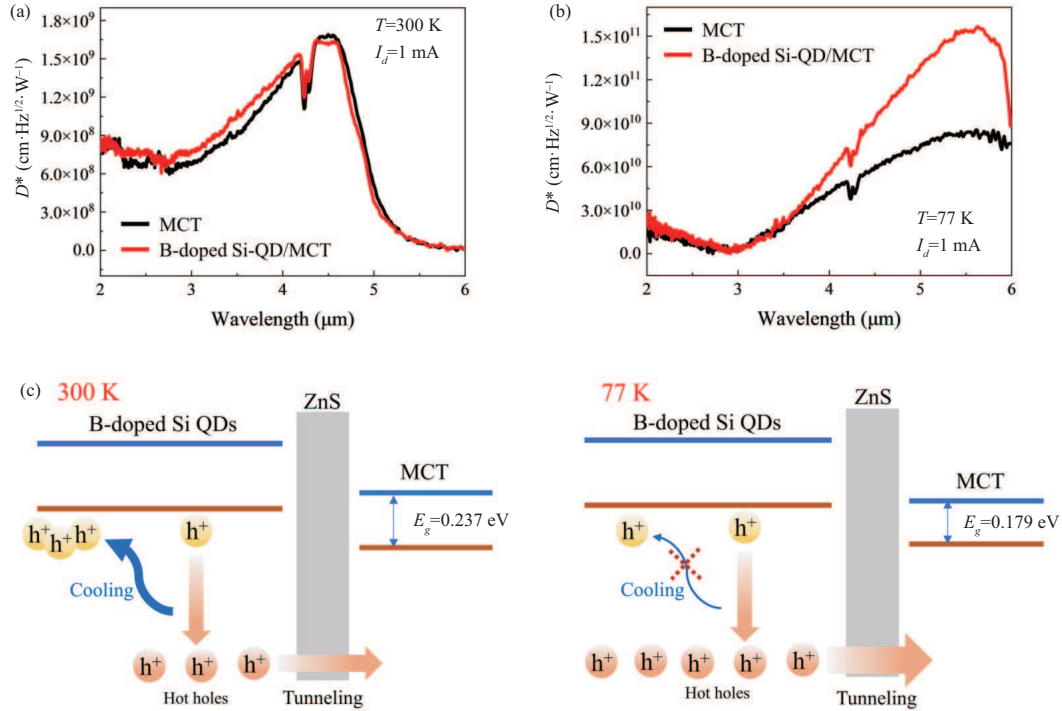


**Figure 2** (Color online) Photoresponse characterization of the B-doped Si-QD/HgCdTe device. (a) Drain source current of the photodetector under different power densities at 4  $\mu\text{m}$ ; (b) photocurrent and specific detectivity of the photodetector as a function of the power density,  $V_{\text{ds}} = 0.5$  V; (c) photocurrents of the photodetector as a function of  $V_{\text{ds}}$  under varying power density with a laser wavelength of 3  $\mu\text{m}$ ; (d) the photocurrent is a function of the wavelength, with the power density of the irradiation laser fixed at  $-16$   $\text{mW}\cdot\text{cm}^{-2}$ ; (e) normalized photocurrent response of the photodetector under 2.8  $\mu\text{m}$  (1.5 mW),  $V_{\text{ds}} = 0.5$  V. The solid orange (blue) curve is the fit to the original data in the orange (blue) circle.

to the change of LSPR behavior in B-doped Si QDs under a cryogenic environment. To be specific, the carrier concentration in B-doped Si QDs is decreased with lowering the temperature, which enables LSPR peak shifting to longer wavelengths. The carrier concentration dependent plasmon resonance wavelength ( $\lambda_p$ ) can be depicted by the following equation [43–45]:

$$\lambda_p \propto 1/\omega_p = \sqrt{\frac{\varepsilon_0 m_e}{nq^2}}, \quad (5)$$

where  $\omega_p$  is the bulk plasmon frequency,  $\varepsilon_0$  is the permittivity of free space,  $n$  is the free carrier concentration,  $m_e$  is the effective mass of the free carrier, and  $q$  is the elementary charge. It should be noted that the amplitude of blackbody detectivity enhancement at 77 K is higher than that at 300 K, attributed to the increased hot-hole injection under low temperature. The detail mechanism for explaining the temperature dependent performance is illustrated in Figure 3(c). The non-radiative decay of plasmon resonance in B-doped Si QDs can cause the energy transfer from the incident photon to holes, and excites them from the valence band maximum (VBM) to higher energy levels [30, 34, 46]. The hot



**Figure 3** (Color online) (a) Blackbody detectivity of the MCT and B-doped Si-QD/MCT photodetector at different wavelengths under 300 K. (b) Blackbody detectivity of the MCT and B-doped Si-QD/MCT photodetector under 77 K. The small concavity at  $\sim 4.25 \mu\text{m}$  in (a) and (b) is primarily due to carbon dioxide ( $\text{CO}_2$ ) absorption [12]. (c) Schematic sketch of the hot-hole tunneling mechanism at different temperatures.

holes generated in B-doped Si QDs, which have sufficient kinetic energy, can tunnel directly through the ZnS barrier and inject into MCT. Under 300 K, the intra-band cooling of hot holes from high-energetic states to the edge of valence band ( $E_v$ ) acts as a competition with hot-hole tunneling, which decreases the efficiency of hot-hole harvesting. While under low temperature, the cooling processes (hole-phonon scattering and phonon-phonon scattering) [47] are effectively suppressed, which dramatically increases the efficiency of hot-hole tunneling and enables higher sensitivity of the hybrid devices.

### 3 Conclusion

We have demonstrated an MIR photodetector with ultrafast photoresponse and outstanding sensitivity. The performance of the plasmonic B-doped Si-QD/MCT device in the MIR region is distinctly improved by the hot-hole tunneling and LSPR-enhanced light absorption. At room temperature, the device shows high specific detectivity beyond  $\sim 10^9$  Jones and a fast photoresponse ( $\sim 224$  ns for the rise time and  $\sim 580$  ns for the fall time). Furthermore, in a cryogenic environment, the blackbody detectivity of the Si-QD/MCT device can reach  $\sim 1.6 \times 10^{11}$  Jones. These results guide state-of-the-art MIR photodetector construction.

**Methods.** Si QDs synthesis: B-doped Si QDs were synthesized using a nonthermal plasma system whose cavity is a quartz tube [29,30]. A mixture of three gases was used: 1:9  $\text{SiH}_4/\text{Ar}$  mixture, 0.5:99.5  $\text{B}_2\text{H}_6/\text{Ar}$  mixture and Ar, and their flow rates were 12, 30, and 100 sccm, respectively. The pressure in the chamber used to synthesize Si QDs was maintained at  $\sim 3$  mbar. The RF power was approximately 40 W. The  $3 \text{ mg} \cdot \text{mL}^{-1}$  B-doped Si QDs colloids were obtained by mixing a specific ratio of B-doped Si QDs powder with absolute ethanol, followed by ultrasonication.

Si QDs characterization: The doping concentration of B-doped Si QDs was measured by inductively coupled plasma atomic emission spectrometry (ICP-AES) using a Thermal Scientific iCAP6300. To prepare TEM samples, a copper grid with ultra-thin carbon films was used as the substrate, and the colloid solution was dropped on it. Based on these prepared samples, FEI Tecnai F20 was able to conduct the TEM measurements. BRUKER IFS 66V/S was employed to do the FTIR measurements.

Photodetector fabrication: The  $8 \mu\text{m}$   $\text{Hg}_{1-x}\text{Cd}_x\text{Te}$  material was grown by a mobile heating process,

where  $x = 0.26$ . Its shape was designed to be S-shaped, and the photosensitive surface was  $\sim 6.4 \times 10^5 \mu\text{m}^2$ . The upper surface of the MCT was uniformly covered with a layer of ZnS with thickness of  $\sim 10$  nm. B-doped Si QDs were spun-coated onto the MCT at  $3000 \text{ r}\cdot\text{min}^{-1}$  and left to dry naturally.

**Photoresponse measurement:** The photoelectronic measurements of the photodetector were performed under the excitation of MIR laser (spot radius of  $\sim 2$  mm with tunable wavelength, Cait-T-3-4). The response time of the photodetector was measured using a pulse laser (Libra, Coherent) and OPA (OperA, Coherent). The electrical and photoresponse measurements were characterized using a Keithley 2612 analyzer at room temperature. Blackbody test data were acquired with a blackbody radiation source (HFY-200BI), a lock-in amplifier (MODEL 124A), and a current source (KEITHLEY 220 PROGRAMMABLE CURRENT SOURCE). An FTIR spectrometer (Varian 3100 FTIR Excalibur series) was used to analyze the relative spectral response. The photodetectors were placed in a dewar with a cold shield for the blackbody test (300 K and 77 K), and the temperature of the blackbody radiation source was 500 K.

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**Supporting information** Appendixes A–C. The supporting information is available online at [info.scichina.com](http://info.scichina.com) and [link.springer.com](http://link.springer.com). The supporting materials are published as submitted, without typesetting or editing. The responsibility for scientific accuracy and content remains entirely with the authors.

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